

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/612,781	MONACHINO ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2004/0061781 A1	04-2004	Fennell et al.	348/169
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